

**Search Notes**

Application/Control No.

10/589,613

Examiner

Jinhee J. Lee

Applicant(s)/Patent under  
Reexamination

MENDIS ET AL.

Art Unit

2174

**SEARCHED**

Class	Subclass	Date	Examiner
715	721,723, 724,716	3/11/2008	LEE

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
715	as above	3/11/2008	LEE

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East search attached	3/16/2008	LEE